

Notice of References Cited	Application/Control No. 10/724,951		Applicant(s)/Patent Under Reexamination CHAN ET AL.	
	Examiner Sam K. Ahn		Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,043,707	03-2000	Budnik, Brian Joseph	330/10
*	B	US-6,166,598	12-2000	Schlueter, David	330/127
*	C	US-6,205,127	03-2001	Ramesh, Nallepilli Subramanian	370/329
*	D	US-6,535,066	03-2003	Petsko, David	330/285
*	E	US-2003/0176202	09-2003	Bartl et al.	455/522
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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